EMU/AHGA -

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NAME		FAILURE					
P/N QTY	CRIT	MODE & CAUSES	FAILURE EFFECT	, RATIONALE FOR ACCEPTANCE			
~			,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,				
Battery	1/1	106FN30: (aternal	END ITCM:	A. Design -			
Pack Assy. SED13101665-301		short resulting in venting/explosion.	Explosion damaging SSA and causing suit gas leakage to ambient.	The LiBCX call uses lithium (LI) as the anode and thionyl chlorida (SOC1_) with 16 percent bromine chlorida (BrC)) as the catholyte			
(1)		CAUSE:		reacting on an inert carbon cathode to produce an open circuit voltage			
		Excessive vibration, shock or impact.	GFE INTERFACE: Rapid depressurization of	of 3.9 wolts. The normal operating temperature range for the LiBCX cell is -40°F to 162°F. A fiberglass separator material between the			
		Defective soperator	SSA.	positive and negative electrodes is designed to provide ion conduction			
		membrana.	HASSION:	while insulating against internal shorts. The cell contents are contained in an approximately 1 mm thick 30% stainless steel case with			

HASSION: Lose of mission.

CREW/VEHICLE: Loss of cromman.

## modified to resist leaking and venting at temperatures up to 300°F (Report NAS 9-1770) and JSC 22940, "LIBCX D-Cell Delta Qual").

B. Test -

## Acceptance:

a. Vendor cell lot certification (acceptance) tests (JSC EP5--B3-025B). A certified lot is defined as a set of cells which has been consecutively made within 2 consecutive calendar days using a single batch of electrolyte mix. Additionally, the cells are made from one batch of enode, cathode, and separator material. To certify a lot, a sample (20 percent minimum) of a lot is subjected to the following tests performed by the vendor.

a welded metal lid. As of February 1987, the "D" cell design has been

- (i) <u>Capacity Discharge</u> one sample (6 percent) of cells are discharged through a 20 ohm load at 70°F until reaching a cutoff voltage of 2 volts. <u>Pass/Fall Criterion</u> average capacity must be greater than 13 ampare-hours. <u>Fuse Check</u> 3 ampere fuse must blow within 15 seconds at 6 amperes. <u>Overdischarge Interance</u> 3 weeks after the discharge test, the cells are overdischarged at low current for 2D hours at 160°F. <u>Pass/Fail Criterion</u> no venting or rupture of cell material.
- (2) High Temperature Exposure a second (6 percent) is placed in an

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NAME FAILURE
P/N HODE &
GTY CRIT CAUSES FAILURE EFFECT RATIONALE FOR ACCEPTANCE

Battery Pack Assy. SED13101665-301 1/1

106FM30: Internal short resulting in venting/explosion.

(1)

- B. Test (continued)
- (3) Short Circuit Tolerance a third sample (4 percent) is electrically shorted through a load equal to loss than 50 milliohms. Pass/Fal) Criterion no venting or leakage.
- (4) A sample of one "0" cell per lot is tested to  $300^{\circ}\mathrm{F}$  for 15 minutes. It must not leak or vent during this period.
- (5) A sample of four cells per lot are subjected to random vibration for 15 minutes/axis prior to being discharged for capacity information. The random vibration testing is identical to that for MASA acceptance in "b.(2)" below.
- b. NASA Cell Acceptance Test (TYA-t-2p109, revision 8).
- Yisual and open circuit voltage (DCV) tests are performed on 100 percent of delivered calls.
- (2) A sample from each lot of the cells are tested to the following spectrum by the vendor or are delivered to NASA who subjects them to acceptance vibration test for 15 minutes in each of three mutually perpendicular axes, according to the following spectrum, before being discharged for capacity information.

FREQUENCY (Hz) LEVEL
20 to 80 + 3 dly/octave
80 to 350 0.1 g²/llz
350 to 2000 -3db/octave

The OCV is munitored during testing and a load test is performed after vibration testing is complete.

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CIL CRITICAL ITEMS LIST DOCUMENT NO. 0111-711630 RELEASE DATE OF

	FAILURE			
	INTEDIAL			
		CALLUDE FEFFET		
CRIT	CAUSES			
	CRIT	MODE & CRIT CAUSES	COLT CAUSES FAILURE EFFECT	VALUE FFFECT

106FM30:

Internal short

venting/explosion.

resulting in

1/1

RATIONALE FOR ACCEPTANCE

B. Test - (continued)

## Cartifi<u>cation</u>:

During call cartification (JSC-EPS-+Bi-008), the LiBCX call was evaluated over a variety of performance and off limits test conditions in order to meet the three basic requirements for certification:

- a. Capacity performance.
- Venting temperature under off limits testing.
- c. Vibration.

. The lithium "D" battery cell was subjected to the following vibration tests conducted at Ames Research Center. Although the vibration levels were higher than the specification requirement, the battery cells did not experience any failures for the duration of 300 seconds in each of 3 sxes.

LEVEL .106 • .210g<sub>2</sub>/Hz FREQUENCY (H ) 20 - 100 ,210g<sub>2</sub>/Hz ,210 - ,150g²/Hz 100 - 400 400 - 2000

## TURNAROUND:

After a cell configuration has been certified, each cell is usable for flight for 1 year from date of manufacture. This nonrechargeable call may be reflown as long as it was not activated during flight. Once a cell has had any use (no matter how limited) during a flight, it is removed from inventory and submitted for disposal. Unused cells are subjected to a visual inspection, OCV, and load test and returned to flight status, provided the 1 year shalf life has not expired.

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Battery

(1)

Pack Assy.

SE011101665-301

FAILURE NAME NODE & P/N RATIONALE FOR ACCEPTANCE FAILURE EFFECT CAUSES CRIT QTY C. Inspection -106FMJ0: 1/1 Battery Internal short During vendor cell manufacturing/acceptance test (JSC-EPS-83-025), 100 Pack Assy. resulting in SED13101665-401 venting/explosion.

(1)

percent of the calls are manufactured under on site defense contract administration services (DCAS) delegation.

- Electrode plates and separator material are checked for burrs and nisalignment.
- b. Ohmic resistance across the dry cell terminal is checked.
- o. Each cell is identified by a serial number.
- d. Prior to filling the call with electrolyte, each cell is x-rayed in two directions to examine this assembled internal configuration.
- e. The cells are put in an oven at 160°F for 2 hours followed by:
  - (1) QCT Test must be greater than 3.85 volts.
  - (2) Load Test must be greater than 3.5 volts.
  - (3) Size and meight chuck to verify no swelling or venting occurred.
- D. Fallura History -Nane.
- E. Ground Turnaround -Nune.
- F. Operational Use -Нопе,

FMEA CMU FAILURE MODE, EFFECT ANALYSIS DOCUMENT NO. 0111-731630 RELEASE DATE(X6/14/95 PAGE 24 OF 40

NAME P/N OTY	FUNCT ION	FAILURE MODE 4 CAUSES	N&SS TON PHASE	FAILURE EFFECT	FAILURE DETECTION FLIGHT/GROUND	TIME TO EFFECT/ ACTIONS	CR IT	REMARKS/ HAZARD	REF
Battery Pack Assembly SED13101665 -301 [1]	Provides electrical power with over temp protection and fusing.	106FH30: Internal short resulting in venting/ explosion. CAUSE: Excessive vibration, shock or impact. Defective separator membrane.	PreEVA EVA PostEYA	END ITEN: Explosion damaging SSA and causing suit gas lenkage to ambient.  CFE INTERFACE: Rapid depressurization of SSA.  NISSION: Loss of mission.  CREW/VEHICLE: Loss of crewman.	FLIGHTI None. GROUND: None.	None. TIME AVAILABLE: N/A TIME REQUIRED: N/A	1/1 A - N/A B - N/A C - H/A		